

<i>Search Notes</i>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10566950	NARIHIRO ET AL.
	Examiner	Art Unit
	MICHAEL E NELSON	1794

SEARCHED			
Class	Subclass	Date	Examiner
528	423	7/29/2008	Michael E. Nelson
526	259, 310	7/29/2008	Michael E. Nelson
428	690, 917	7/29/2008	Michael E. Nelson
313	502-509	7/29/2008	Michael E. Nelson
275	40, 88-103, E51.001-E51.052	7/29/2008	Michael E. Nelson

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor Name Search in eDAN	7/29/2008	Michael E. Nelson	
See Attached EAST Search History	7/29/2008	Michael E. Nelson	
Structure search from EIC	7/29/2008	Michael E. Nelson	
Structure search in STN	7/29/2008	Michael E. Nelson	
updated EAST search (see printout)	2/22/2009	D. Garrett	
EIC 1700 STIC structure search (see attached)	2/5/2009	D. Garrett	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner